

DRV8872-Q1 オートモーティブ、3.6Aブラシ付きDCモータ・ドライバ、エラー報告機能付き

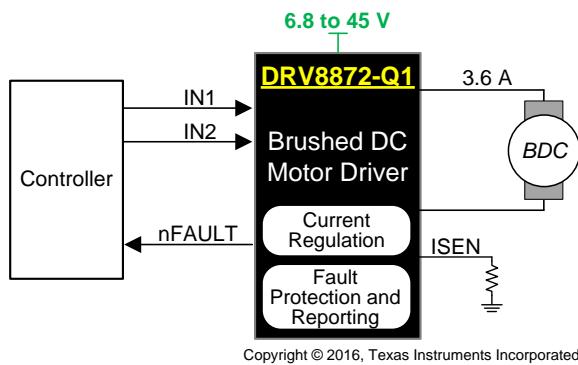
1 特長

- 車載アプリケーション用にAEC-Q100認定済み:
 - デバイス温度グレード1: 動作時周囲温度範囲 $-40^{\circ}\text{C} \sim +125^{\circ}\text{C}$
 - デバイスHBM ESD分類レベル2
 - デバイスCDM ESD分類レベルC4B
- Hブリッジ・モータ・ドライバ
 - 1台のDCモータ、ステッピング・モータの1つの巻線、またはその他の負荷を駆動
- 6.8V~45Vの広い動作電圧範囲
- 標準値 $565\text{m}\Omega$ の直流オン抵抗(ハイサイドとローサイド)
- 3.6Aのピーク駆動電流
- PWM制御インターフェイス
- 電流レギュレーション機能を内蔵
- 低電力スリープ・モード
- エラー状態出力ピン
- 小さなパッケージと占有面積
 - 8ピンHSOP: PowerPAD™
 - $4.9 \times 6 \text{ mm}$
- 保護機能を内蔵
 - VM低電圧誤動作防止(UVLO)
 - 過電流保護(OCP)
 - サーマル・シャットダウン(TSD)
 - エラー報告機能(nFAULT)
 - エラーからの自動復旧

2 アプリケーション

- 車載インフォテインメント
- HUDプロジェクタの調整
- 電動シフター・ノブ
- 圧電型ホーン・ドライバ

概略回路図



3 概要

DRV8872-Q1デバイスは、情報エンターテインメント、HUDプロジェクタの調整、電動シフター・ノブ、圧電型ホーン・ドライバ向けのブラシ付きDC (BDC) モータ・ドライバです。2つのロジック入力がHブリッジ・ドライバを制御します。ドライバは4つのnチャネルMOSFETを装備し、最大ピーク電流3.6Aまでのモータを双方向制御します。入力をパルス幅変調(PWM)し電流減衰モードを選択してモータ回転数を制御できます。両方の入力を“L”にすると低消費電力スリープ・モードになります。

DRV8872-Q1デバイスは、内部基準電圧またはISENピンの電圧を基準にできる電流レギュレーション機能を内蔵しており、ISENピンには、外付けの検出抵抗器を通るモータ電流に比例した電圧が印加されます。電流を既知のレベルに制限できるため、システムに必要な電力を大幅に低減でき、特にモータの始動時や失速時に安定した電圧を維持するのに必要なバルク容量も低減できます。

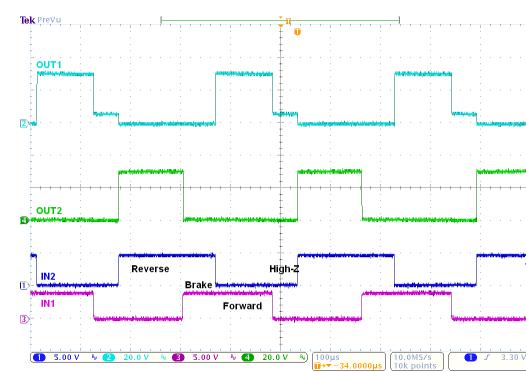
デバイスは、低電圧誤動作防止(UVLO)、過電流保護(OCP)、サーマル・シャットダウン(TSD)などの機能によりエラーや短絡から完全に保護されています。エラーの場合は、nFAULT出力が“L”になることで通知されます。エラー状態が解消されると、デバイスは自動的に通常動作状態に復帰します。

製品情報⁽¹⁾

型番	パッケージ	本体サイズ(公称)
DRV8872-Q1	HSOP (8)	4.90mm×6.00mm

(1) 提供されているすべてのパッケージについては、巻末の注文情報をお参照ください。

Hブリッジのステータス



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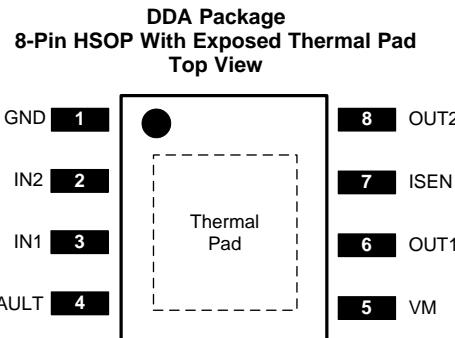
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4 改訂履歴

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

日付	改訂内容	注
2016年11月	*	初版

5 Pin Configuration and Functions



Pin Functions

PIN		TYPE	DESCRIPTION	
NAME	NO.			
GND	1	PWR	Logic ground	Connect to board ground.
IN1	3	I	Logic inputs	Controls the H-bridge output. Has internal pulldowns. (See 表 1.)
IN2	2			
ISEN	7	PWR	High-current ground path	If using current regulation, connect ISEN to a resistor (low-value, high-power-rating) to ground. If not using current regulation, connect ISEN directly to ground.
nFAULT	4	OD	Fault status (open-drain)	Low-level indicates UVLO, TSD, or OCP fault. Connect to a pullup resistor.
OUT1	6	O	H-bridge outputs	Connect directly to the motor, or other inductive load.
OUT2	8			
VM	5	PWR	6.8-V to 45-V power supply	Connect a 0.1- μ F bypass capacitor to ground, as well as sufficient bulk capacitance, rated for the VM voltage.
PAD	—	—	Thermal pad	Connect to board ground. For good thermal dissipation, use large ground planes on multiple layers, and multiple nearby vias connecting those planes.

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

	MIN	MAX	UNIT
Power supply voltage (VM)	-0.3	50	V
Logic input voltage (IN1, IN2)	-0.3	7	V
Fault pin (nFAULT)	-0.3	6	V
Continuous phase node pin voltage (OUT1, OUT2)	-0.7	VM + 0.7	V
Current sense input pin voltage (ISEN) ⁽²⁾	-0.5	1	V
Output current (100% duty cycle)		3.5	A
Operating junction temperature, T _J	-40	150	°C
Storage temperature, T _{stg}	-65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) Transients of ± 1 V for less than 25 ns are acceptable

6.2 ESD Ratings

		VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human-body model (HBM), per AEC Q100-002 ⁽¹⁾	±2000
		Charged-device model (CDM), per AEC Q100-011	All pins Corner pins (1, 4, 5, and 8) ±500 ±750

(1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
VM	Power supply voltage	6.8	45	V	
V _I	Logic input voltage (IN1, IN2)	0	5.5	V	
f _{PWM}	Logic input PWM frequency (IN1, IN2)	0	200 ⁽¹⁾	kHz	
I _{peak}	Peak output current ⁽²⁾	0	3.6	A	
T _A	Operating ambient temperature	-40	125	°C	

- (1) The voltages applied to the inputs should have at least 800 ns of pulse width to ensure detection. Typical devices require at least 400 ns. If the PWM frequency is 200 kHz, the usable duty cycle range is 16% to 84%
- (2) Power dissipation and thermal limits must be observed

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		DRV8872-Q1	UNIT
		DDA (HSOP)	
		8 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	41.7	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	53.7	°C/W
R _{θJB}	Junction-to-board thermal resistance	12.4	°C/W
Ψ _{JT}	Junction-to-top characterization parameter	3	°C/W
Ψ _{JB}	Junction-to-board characterization parameter	12.6	°C/W
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	2.6	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report (SPRA953).

6.5 Electrical Characteristics

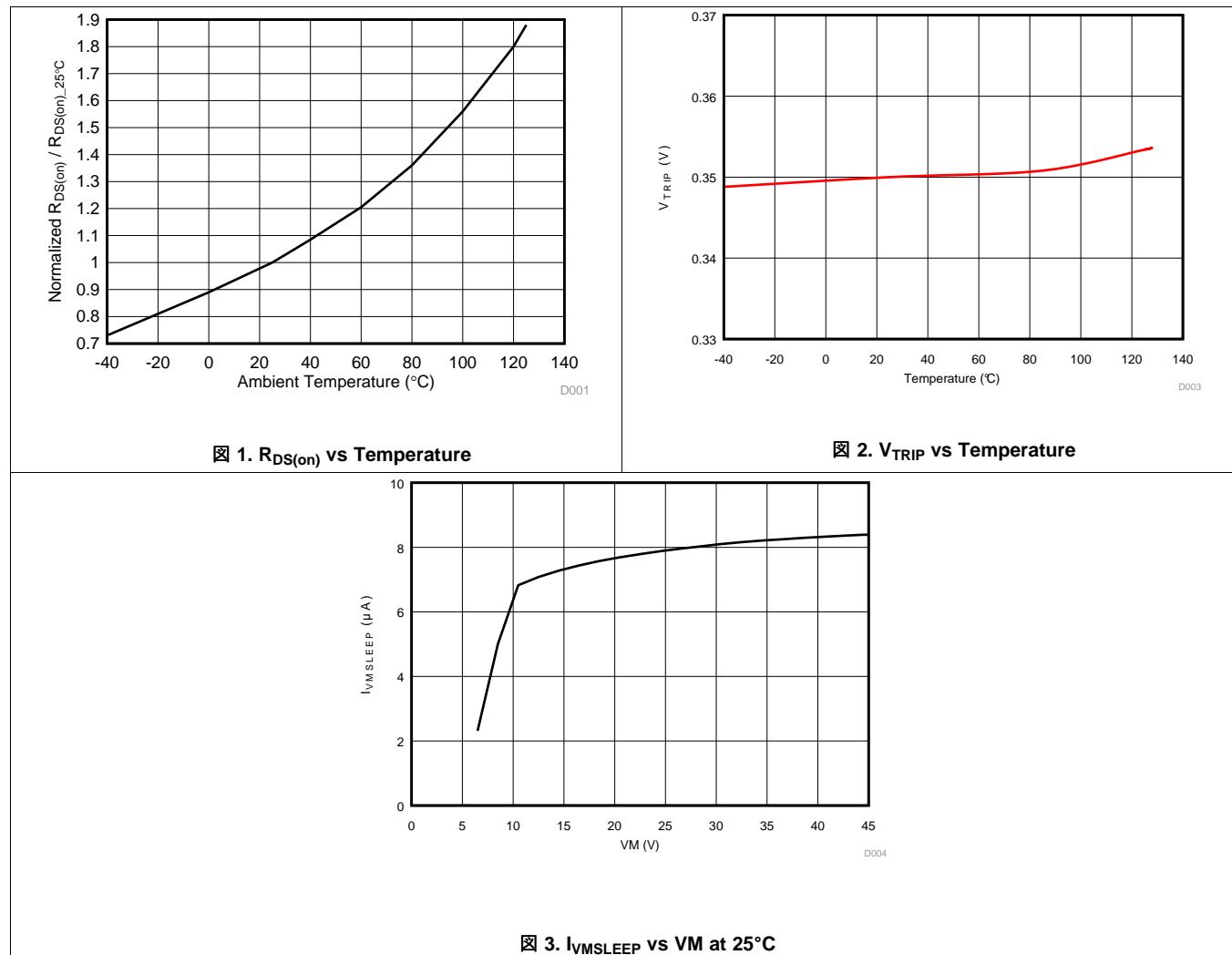
Over recommended operating conditions unless otherwise noted. Typical limits apply for $T_A = 25^\circ\text{C}$ and $V_{VM} = 24\text{ V}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
POWER SUPPLY (VM)					
V_{VM}	VM operating voltage	6.8	45		V
I_{VM}	VM operating supply current		3	10	mA
$I_{VMSLEEP}$	VM sleep current	VM = 12 V		13	μA
t_{ON}	Turnon time ⁽¹⁾	VM > V_{UVLO} with IN1 or IN2 high	40	50	μs
LOGIC-LEVEL INPUTS (IN1, IN2)					
V_{IL}	Input logic low voltage		0.5		V
V_{IH}	Input logic high voltage	1.6			V
V_{HYS}	Input logic hysteresis		0.5		V
I_{IL}	Input logic low current	$V_{IN} = 0\text{ V}$	-1	1	μA
I_{IH}	Input logic high current	$V_{IN} = 3.3\text{ V}$	33	100	μA
R_{PD}	Pulldown resistance	To GND	100		$\text{k}\Omega$
t_{PD}	Propagation delay	INx to OUTx change (see FIG 6)	0.7	1	μs
t_{sleep}	Time to sleep	Inputs low to sleep	1	1.5	ms
MOTOR DRIVER OUTPUTS (OUT1, OUT2)					
$R_{DS(ON)}$	High-side FET on resistance	VM = 24 V, $I = 1\text{ A}$, $f_{PWM} = 25\text{ kHz}$	307	610	$\text{m}\Omega$
$R_{DS(ON)}$	Low-side FET on resistance	VM = 24 V, $I = 1\text{ A}$, $f_{PWM} = 25\text{ kHz}$	258	500	$\text{m}\Omega$
t_{DEAD}	Output dead time		250		ns
V_d	Body diode forward voltage	$I_{OUT} = 1\text{ A}$	0.8	1	V
CURRENT REGULATION					
V_{TRIP}	ISEN voltage for current chopping		0.32	0.35	0.38
t_{OFF}	PWM off-time		25		μs
t_{BLANK}	PWM blanking time		2		μs
PROTECTION CIRCUITS					
V_{UVLO}	VM undervoltage lockout	VM falls until UVLO triggers	6.3	6.5	V
		VM rises until operation recovers	6.4	6.7	
$V_{UV,HYS}$	VM undervoltage hysteresis	Rising to falling threshold	100	180	mV
I_{OCP}	Overcurrent protection trip level		3.7	4.5	6.6
t_{OCP}	Overcurrent deglitch time		2		μs
t_{RETRY}	Overcurrent retry time		3		ms
T_{SD}	Thermal shutdown temperature ⁽²⁾		155	180	$^\circ\text{C}$
T_{HYS}	Thermal shutdown hysteresis ⁽²⁾		40		$^\circ\text{C}$
nFAULT OPEN DRAIN OUTPUT					
V_{OL}	Output low voltage	$I_O = 5\text{ mA}$		0.5	V
I_{OH}	Output high leakage current	$V_O = 3.3\text{ V}$		1	μA

(1) t_{ON} applies when the device initially powers up, and when it exits sleep mode.

(2) Ensured by design

6.6 Typical Characteristics

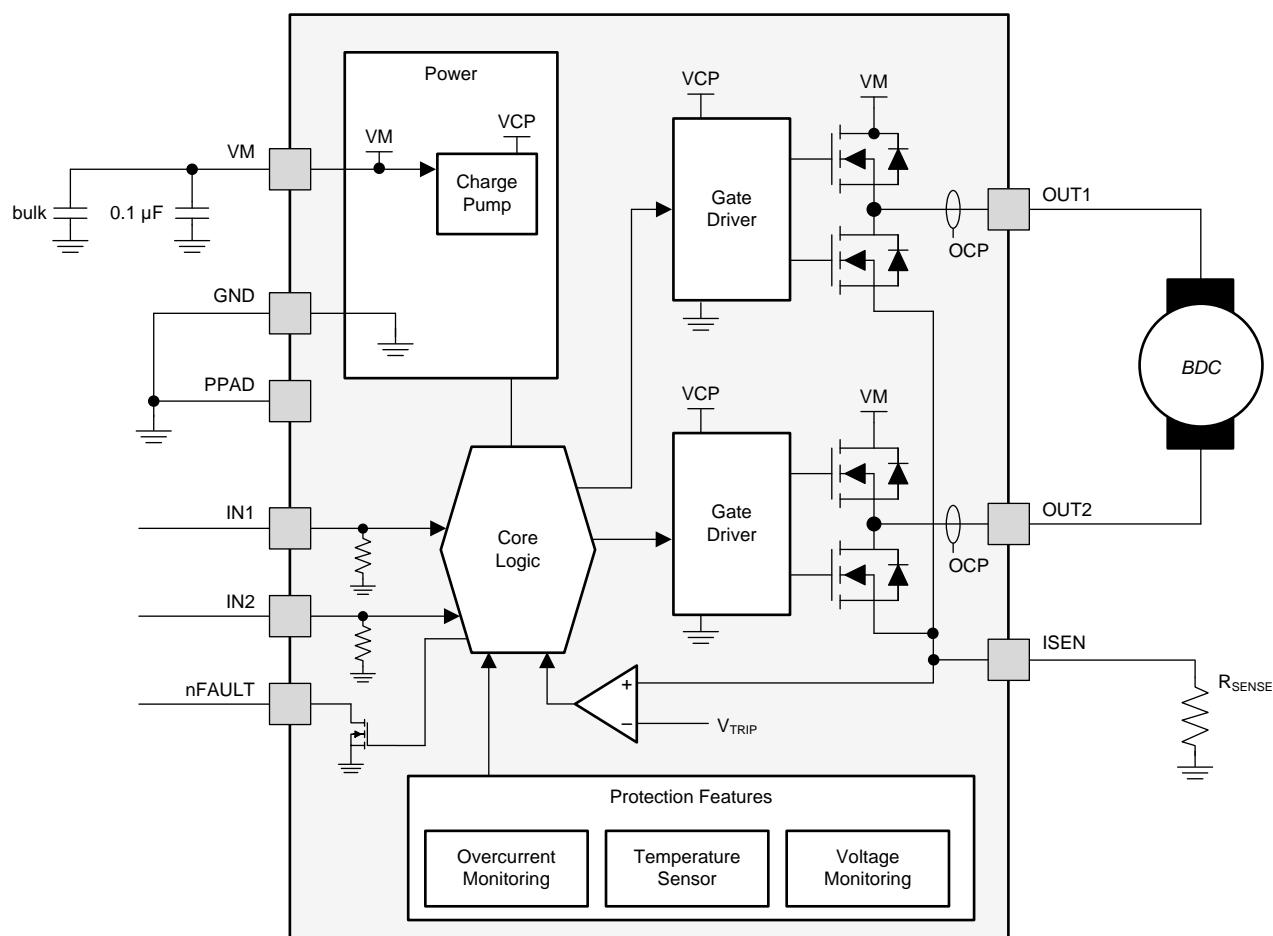


7 Detailed Description

7.1 Overview

The DRV8872-Q1 device is an optimized 8-pin device for driving brushed DC motors with 6.8 to 45 V and up to 3.6-A peak current. The integrated current regulation restricts motor current to a predefined maximum. Two logic inputs control the H-bridge driver, which consists of four N-channel MOSFETs that have a typical $R_{ds(on)}$ of 565 mΩ (including one high-side and one low-side FET). A single power input, VM, serves as both device power and the motor winding bias voltage. The integrated charge pump of the device boosts VM internally and fully enhances the high-side FETs. Motor speed can be controlled with pulse-width modulation, at frequencies between 0 to 200 kHz. The device has an integrated sleep mode that is entered by bringing both inputs low. An assortment of protection features prevent the device from being damaged if a system fault occurs.

7.2 Functional Block Diagram



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7.3 Feature Description

7.3.1 Bridge Control

The DRV8872-Q1 output consists of four N-channel MOSFETs that are designed to drive high current. These MOSFETs are controlled by the two logic inputs IN1 and IN2, according to 表 1.

表 1. H-Bridge Control

IN1	IN2	OUT1	OUT2	DESCRIPTION
0	0	High-Z	High-Z	Coast; H-bridge disabled to High-Z (sleep entered after 1 ms)
0	1	L	H	Reverse (current OUT2 → OUT1)
1	0	H	L	Forward (current OUT1 → OUT2)
1	1	L	L	Brake; low-side slow decay

The inputs can be set to static voltages for 100% duty-cycle drive, or they can be pulse-width modulated (PWM) for variable motor speed. When using PWM, switching between driving and braking typically works best. For example, to drive a motor forward with 50% of its max RPM, IN1 = 1 and IN2 = 0 during the driving period, and IN1 = 1 and IN2 = 1 during the other period. Alternatively, the coast mode (IN1 = 0, IN2 = 0) for *fast current decay* is also available. The input pins can be powered before VM is applied.

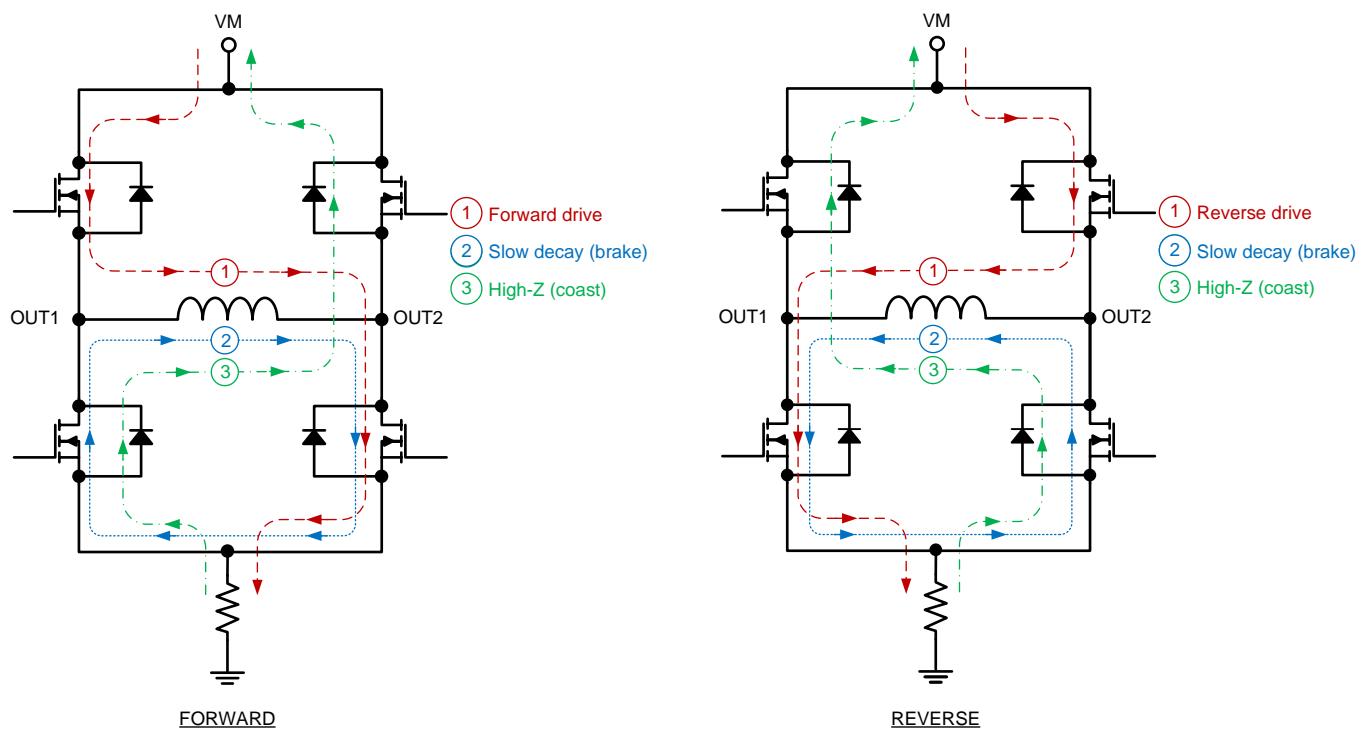


图 4. H-Bridge Current Paths

7.3.2 Sleep Mode

When IN1 and IN2 are both low for time t_{SLEEP} (typically 1 ms), the DRV8872-Q1 device enters a low-power sleep mode, where the outputs remain High-Z and the device uses $I_{VMSLEEP}$ (microamps) of current. If the device is powered up while both inputs are low, sleep mode is immediately entered. After IN1 or IN2 are high for at least 5 μ s, the device is operational 50 μ s (t_{ON}) later.

7.3.3 Current Regulation

The DRV8872-Q1 device limits the output current based on the resistance of an external sense resistor on pin ISEN, according to 式 1.

$$I_{TRIP} (A) = \frac{V_{TRIP} (V)}{R_{ISEN} (\Omega)} = \frac{0.35 (V)}{R_{ISEN} (\Omega)} \quad (1)$$

For example, if $R_{ISEN} = 0.16 \Omega$, the DRV8872-Q1 device limits motor current to 2.2 A no matter how much load torque is applied. For guidelines on selecting a sense resistor, see the [Sense Resistor](#) section.

When I_{TRIP} has been reached, the device enforces slow current decay by enabling both low-side FETs, and it does this for time t_{OFF} (typically 25 μ s).

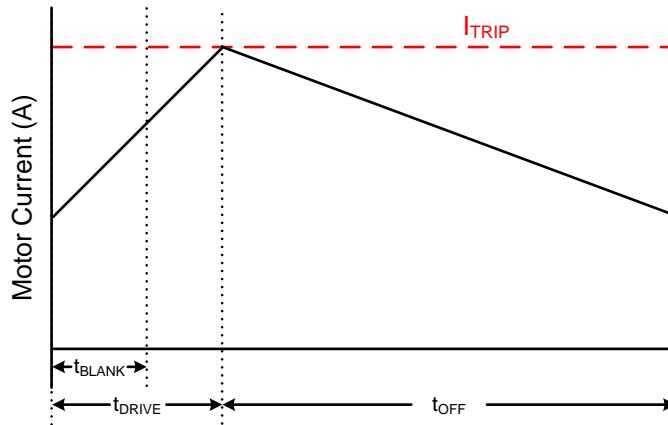


图 5. Current Regulation Time Periods

After t_{OFF} has elapsed, the output is re-enabled according to the two inputs INx. The drive time (t_{DRIVE}) until reaching another I_{TRIP} event heavily depends on the VM voltage, the back-EMF of the motor, and the inductance of the motor.

7.3.4 Dead Time

When an output changes from driving high to driving low, or driving low to driving high, dead time is automatically inserted to prevent shoot-through. t_{DEAD} is the time in the middle when the output is High-Z. If the output pin is measured during t_{DEAD} , the voltage will depend on the direction of current. If current is leaving the pin, the voltage is a diode drop below ground. If current is entering the pin, the voltage is a diode drop above VM. This diode is the body diode of the high-side or low-side FET.

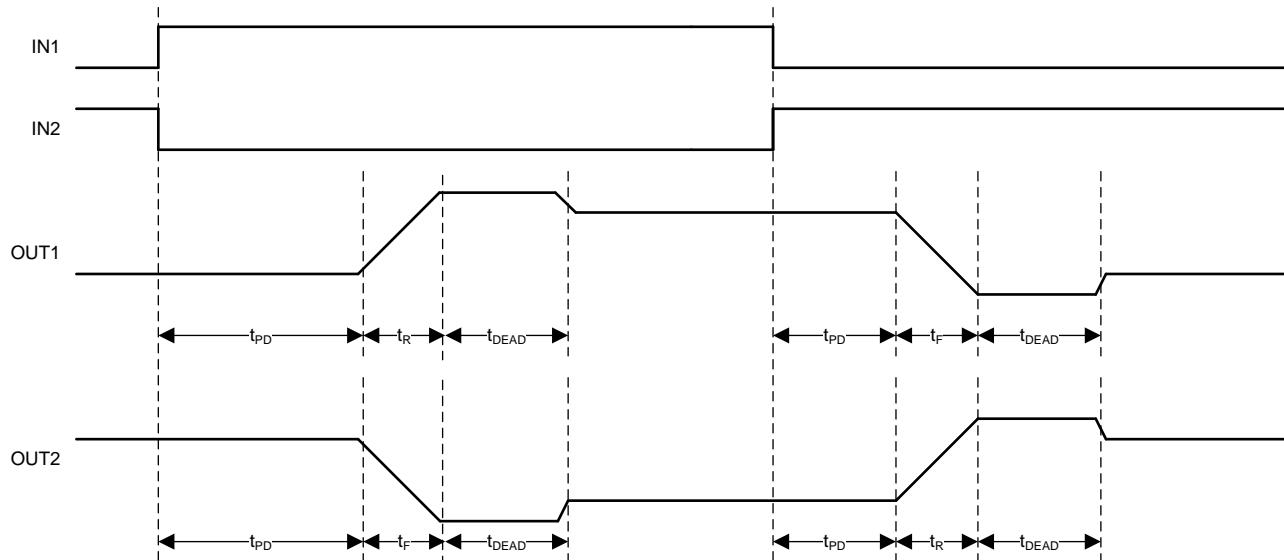


图 6. Propagation Delay Time

7.3.5 Protection Circuits

The DRV8872-Q1 device is fully protected against VM undervoltage, overcurrent, and overtemperature events. When the device is in a protected state, nFAULT is driven low. When the fault condition is removed, nFAULT becomes a high-impedance state.

7.3.5.1 VM Undervoltage Lockout (UVLO)

If at any time the voltage on the VM pin falls below the undervoltage-lockout threshold voltage, all FETs in the H-bridge are disabled. Operation resumes when VM rises above the UVLO threshold.

7.3.5.2 Overcurrent Protection (OCP)

If the output current exceeds the OCP threshold I_{OCP} for longer than t_{OCP} , all FETs in the H-bridge are disabled for a duration of t_{RETRY} . After that, the H-bridge re-enables according to the state of the INx pins. If the overcurrent fault is still present, the cycle repeats; otherwise normal device operation resumes.

7.3.5.3 Thermal Shutdown (TSD)

If the die temperature exceeds safe limits, all FETs in the H-bridge is disabled. After the die temperature has fallen to a safe level, operation automatically resumes.

表 2. Protection Functionality

FAULT	CONDITION	H-BRIDGE BECOMES	NFAULT BECOMES	RECOVERY
VM undervoltage lockout (UVLO)	$VM < V_{UVLO}$	Disabled	Low	$VM > V_{UVLO}$
Overcurrent (OCP)	$I_{OUT} > I_{OCP}$	Disabled	Low	t_{RETRY}
Thermal shutdown (TSD)	$T_J > 150^\circ C$	Disabled	Low	$T_J < T_{SD} - T_{HYS}$

7.4 Device Functional Modes

The DRV8872-Q1 device can be used in multiple ways to drive a brushed DC motor.

7.4.1 PWM With Current Regulation

This scheme uses all of the capabilities of the device. The I_{TRIP} current is set above the normal operating current, and high enough to achieve an adequate spin-up time, but low enough to constrain current to a desired level. Motor speed is controlled by the duty cycle of one of the inputs, while the other input is static. Brake and slow decay is typically used during the off-time.

7.4.2 PWM Without Current Regulation

If current regulation is not needed, the ISEN pin should be directly connected to the PCB ground plane. This mode provides the highest possible peak current: up to 3.6 A for a few hundred milliseconds (depending on PCB characteristics and the ambient temperature). If current exceeds 3.6 A, the device might reach overcurrent protection (OCP) or over-temperature shutdown (TSD). If that occurs, the device disables and protects itself for about 3 ms (t_{RETRY}) and then resumes normal operation.

7.4.3 Static Inputs With Current Regulation

The IN1 and IN2 pins can be set high and low for 100% duty cycle drive, and ITRIP can be used to control the current, speed, and torque capability of the motor.

7.4.4 VM Control

In some systems, varying VM as a means of changing motor speed is desirable. See the [Motor Voltage](#) section for more information.

8 Application and Implementation

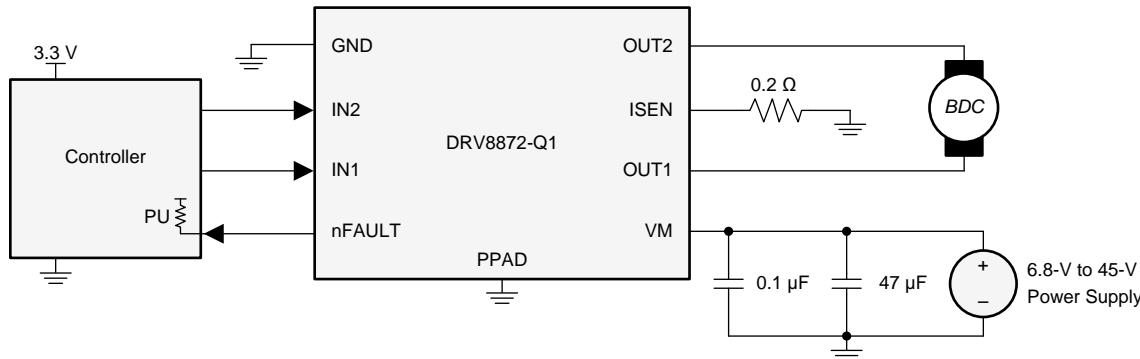
注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The DRV8872-Q1 device is typically used to drive one brushed DC motor.

8.2 Typical Application



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图 7. Typical Connections

8.2.1 Design Requirements

表 3 lists the design parameters.

表 3. Design Parameters

DESIGN PARAMETER	REFERENCE	EXAMPLE VALUE
Motor voltage	V_M	24 V
Motor RMS current	I_{RMS}	0.8 A
Motor startup current	I_{START}	2 A
Motor current trip point	I_{TRIP}	2.2 A
Sense resistance	R_{ISEN}	0.16 Ω
PWM frequency	f_{PWM}	5 kHz

8.2.2 Detailed Design Procedure

8.2.2.1 Motor Voltage

The motor voltage used depends on the ratings of the motor selected and the desired RPM. A higher voltage spins a brushed DC motor faster with the same PWM duty cycle applied to the power FETs. A higher voltage also increases the rate of current change through the inductive motor windings.

8.2.2.2 Drive Current

The current path is through the high-side sourcing DMOS power driver, motor winding, and low-side sinking DMOS power driver. Power dissipation losses in one source and sink DMOS power driver are shown in 式 2.

$$P_D = I^2 (R_{DS(on)Source} + R_{DS(on)Sink}) \quad (2)$$

The DRV8872-Q1 device has been measured to be capable of 2-A RMS current at 25°C on standard FR-4 PCBs. The maximum RMS current varies based on the PCB design, ambient temperature, and PWM frequency. Typically, switching the inputs at 200 kHz compared to 20 kHz causes 20% more power loss in heat.

8.2.2.3 Sense Resistor

For optimal performance, the sense resistor must have the features that follow:

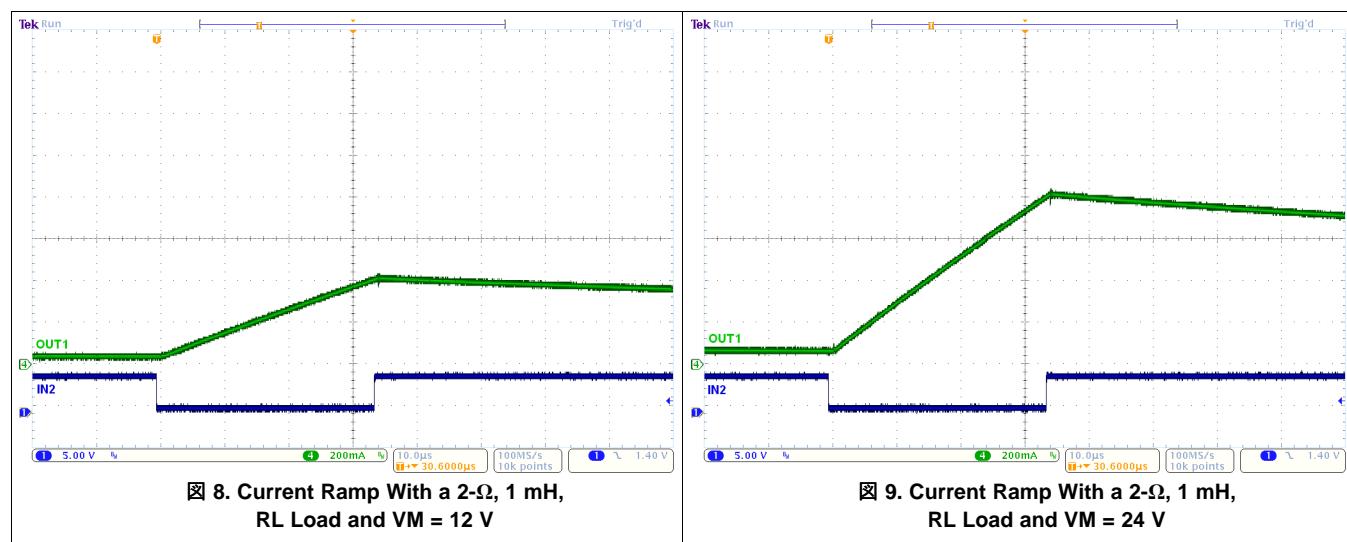
- Surface-mount device
- Low inductance
- Rated for high enough power
- Placed closely to the motor driver

The power dissipated by the sense resistor equals $I_{RMS}^2 \times R$. For example, if peak motor current is 3 A, RMS motor current is 1.5 A, and a 0.2-Ω sense resistor is used, the resistor dissipates $1.5 A^2 \times 0.2 \Omega = 0.45$ W. The power quickly increases with higher current levels.

Resistors typically have a rated power within some ambient temperature range, along with a derated power curve for high ambient temperatures. When a PCB is shared with other components generating heat, the system designer should add margin. It is always best to measure the actual sense resistor temperature in a final system.

Because power resistors are larger and more expensive than standard resistors, multiple standard resistors can be used in parallel, between the sense node and ground. This configuration distributes the current and heat dissipation.

8.2.3 Application Curves



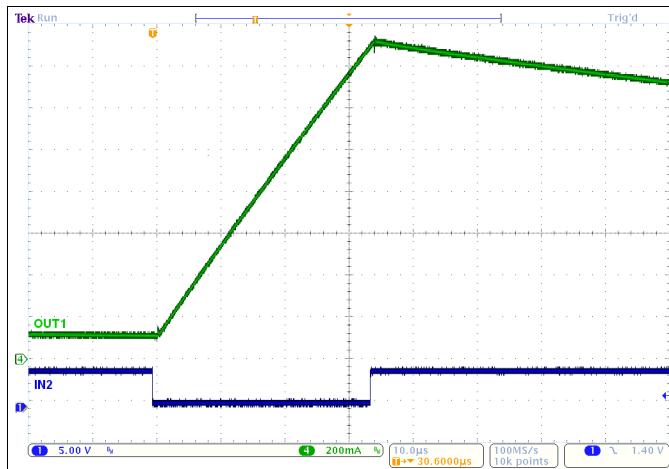


図 10. Current Ramp With a 2-Ω, 1 mH,
RL Load and VM = 45 V

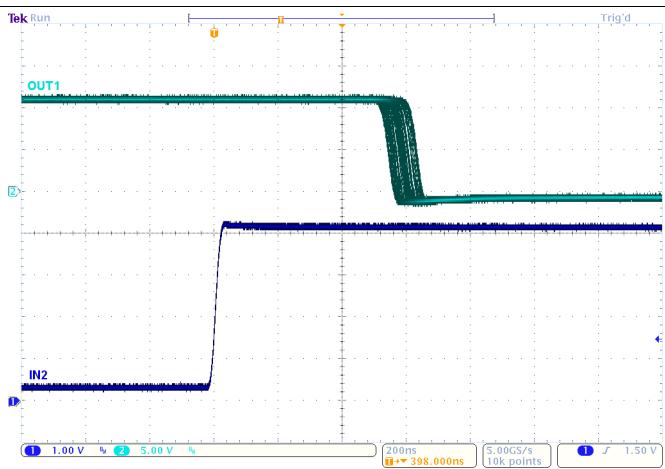


図 11. tPD

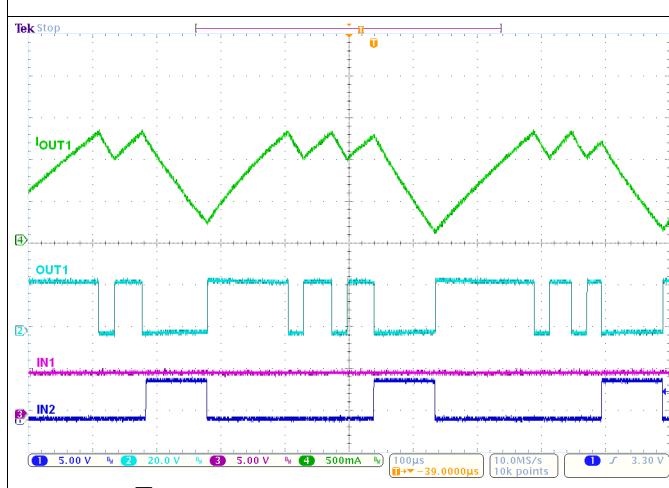


図 12. Current Regulation With $R_{SENSE} = 0.26 \Omega$

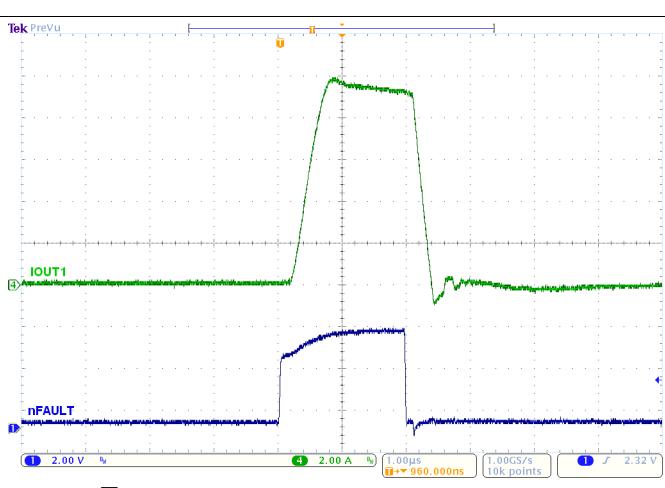


図 13. OCP With 24 V and Outputs Shorted Together

9 Power Supply Recommendations

9.1 Bulk Capacitance

Having appropriate local bulk capacitance is an important factor in motor drive system design. More bulk capacitance is generally beneficial but with the disadvantages of increased cost and physical size.

The amount of local capacitance needed depends on a variety of factors, including:

- The highest current required by the motor system
- The power supply's capacitance and ability to source current
- The amount of parasitic inductance between the power supply and motor system
- The acceptable voltage ripple
- The type of motor used (brushed DC, brushless DC, stepper)
- The motor braking method

The inductance between the power supply and motor drive system limits the rate that the current can change from the power supply. If the local bulk capacitance is too small, the system responds to excessive current demands or dumps from the motor with a change in voltage. When adequate bulk capacitance is used, the motor voltage remains stable and high current can be quickly supplied.

The data sheet generally provides a recommended value, but system-level testing is required to determine the appropriate sized bulk capacitor.

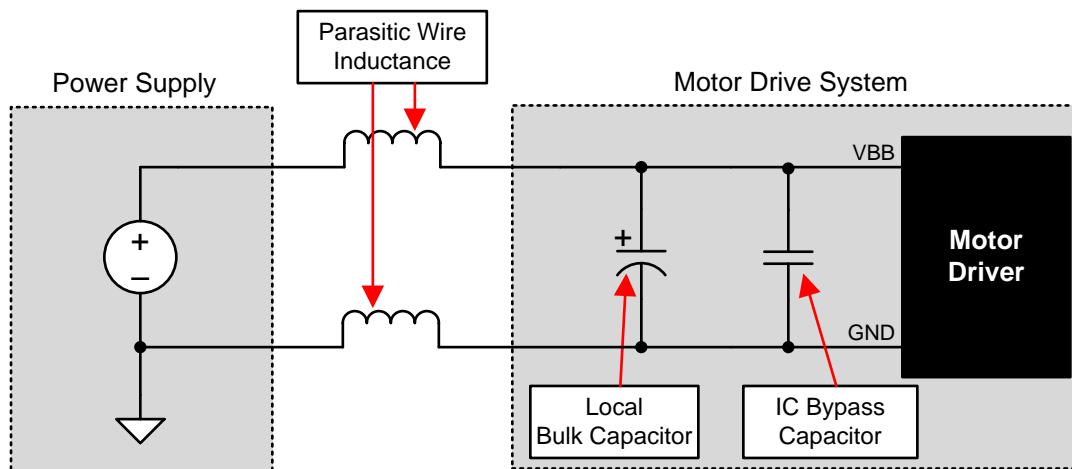


图 14. Example Setup of Motor Drive System With External Power Supply

The voltage rating for bulk capacitors should be higher than the operating voltage, to provide margin for cases when the motor transfers energy to the supply.

10 Layout

10.1 Layout Guidelines

The bulk capacitor should be placed to minimize the distance of the high-current path through the motor driver device. The connecting metal trace widths should be as wide as possible, and numerous vias should be used when connecting PCB layers. These practices minimize inductance and allow the bulk capacitor to deliver high current.

Small-value capacitors should be ceramic, and placed closely to device pins.

The high-current device outputs should use wide metal traces.

The device thermal pad should be soldered to the PCB top-layer ground plane. Multiple vias should be used to connect to a large bottom-layer ground plane. The use of large metal planes and multiple vias help dissipate the $I^2 \times R_{DS(on)}$ heat that is generated in the device.

図 15 shows the recommended layout and component placement.

10.2 Layout Example

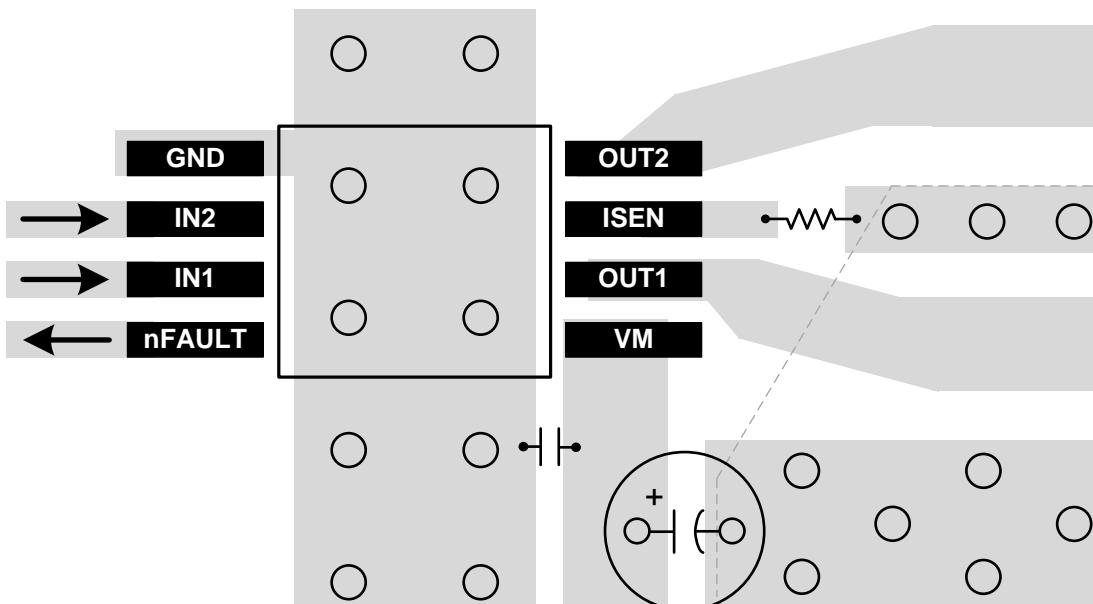


図 15. Layout Recommendation

10.3 Thermal Considerations

The DRV8872-Q1 device has thermal shutdown (TSD) as described in the [Thermal Shutdown \(TSD\)](#) section. If the die temperature exceeds approximately 175°C, the device is disabled until the temperature drops below the temperature hysteresis level.

Any tendency of the device to enter TSD is an indication of either excessive power dissipation, insufficient heatsinking, or too high of an ambient temperature.

10.4 Power Dissipation

Power dissipation in the DRV8872-Q1 device is dominated by the power dissipated in the output FET resistance, $R_{DS(on)}$. Use 式 2 from the [Drive Current](#) section to calculate the estimated average power dissipation of when driving a load.

Note that at startup, the output current is much higher than normal running current; this peak current and its duration must be also be considered.

Power Dissipation (continued)

The maximum amount of power that can be dissipated in the device is dependent on ambient temperature and heatsinking.

注

$R_{DS(ON)}$ increases with temperature, so as the device heats, the power dissipation increases. This fact must be taken into consideration when sizing the heatsink.

The power dissipation of the DRV8872-Q1 is a function of RMS motor current and the FET resistance ($R_{DS(ON)}$) of each output.

$$\text{Power} \approx I_{RMS}^2 \times (\text{High-side } R_{DS(ON)} + \text{Low-side } R_{DS(ON)}) \quad (3)$$

For this example, the ambient temperature is 58°C, and the junction temperature reaches 80°C. At 58°C, the sum of $R_{DS(ON)}$ is about 0.72 Ω. With an example motor current of 0.8 A, the dissipated power in the form of heat is $0.8 \text{ A}^2 \times 0.72 \Omega = 0.46 \text{ W}$.

The temperature that the DRV8872-Q1 reaches depends on the thermal resistance to the air and PCB. Soldering the device PowerPAD to the PCB ground plane, with vias to the top and bottom board layers, is important to dissipate heat into the PCB and reduce the device temperature. In the example used here, the DRV8872-Q1 had an effective thermal resistance $R_{θJA}$ of 48°C/W, and a T_J value as shown in [式 4](#).

$$T_J = T_A + (P_D \times R_{θJA}) = 58^\circ\text{C} + (0.46 \text{ W} \times 48^\circ\text{C}/\text{W}) = 80^\circ\text{C} \quad (4)$$

10.4.1 Heatsinking

The PowerPAD package uses an exposed pad to remove heat from the device. For proper operation, this pad must be thermally connected to copper on the PCB to dissipate heat. On a multi-layer PCB with a ground plane, this connection can be accomplished by adding a number of vias to connect the thermal pad to the ground plane.

On PCBs without internal planes, a copper area can be added on either side of the PCB to dissipate heat. If the copper area is on the opposite side of the PCB from the device, thermal vias are used to transfer the heat between top and bottom layers.

For details about how to design the PCB, refer to the TI application report, [PowerPAD™ Thermally Enhanced Package](#) (SLMA002), and the TI application brief, [PowerPAD Made Easy™](#) (SLMA004), available at www.ti.com. In general, the more copper area that can be provided, the more power can be dissipated.

11 デバイスおよびドキュメントのサポート

11.1 ドキュメントのサポート

11.1.1 関連資料

関連資料については、以下を参照してください。

- 『電流再循環モードと電流減衰モード』(SLVA321)
- 『モータ・ドライバの消費電力の計算』(SLVA504)
- 『DRV8872-Q1を使用したエンジン・グリル・シャッター・モータの駆動』(SLVA858)
- 『放熱特性の優れたPowerPAD™パッケージ』(SLMA002)
- 『PowerPAD™の簡単な使用法』(SLMA004)
- 『モータ・ドライバの電流定格について』(SLVA505)

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11.6 用語集

SLYZ022 — TI用語集

この用語集には、用語や略語の一覧および定義が記載されています。

12 メカニカル、パッケージ、および注文情報

以降のページには、メカニカル、パッケージ、および注文に関する情報が記載されています。この情報は、そのデバイスについて利用可能な最新のデータです。このデータは予告なく変更されることがあります。ドキュメントが改訂される場合もあります。本データシートのブラウザ版を使用されている場合は、画面左側の説明をご覧ください。

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
DRV8872DDARQ1	ACTIVE	SO PowerPAD	DDA	8	2500	RoHS & Green	NIPDAUAG	Level-3-260C-168 HR	-40 to 125	8872Q	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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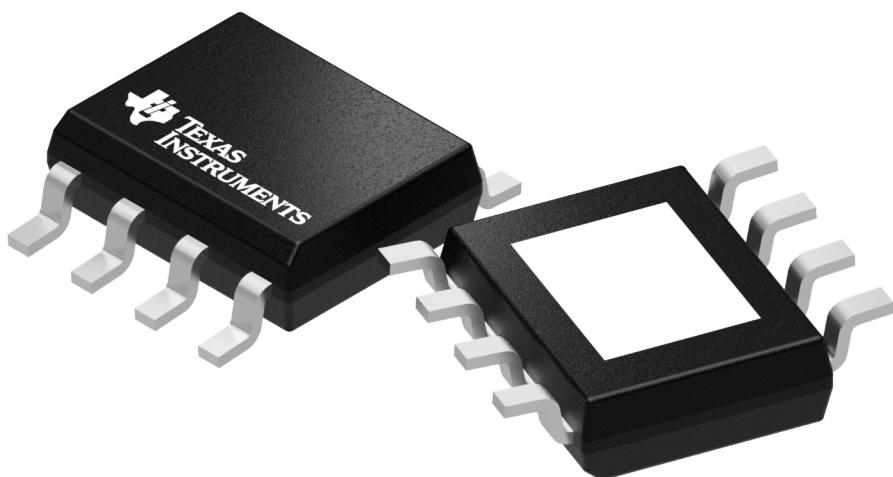
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

GENERIC PACKAGE VIEW

DDA 8

PowerPAD™ SOIC - 1.7 mm max height

PLASTIC SMALL OUTLINE



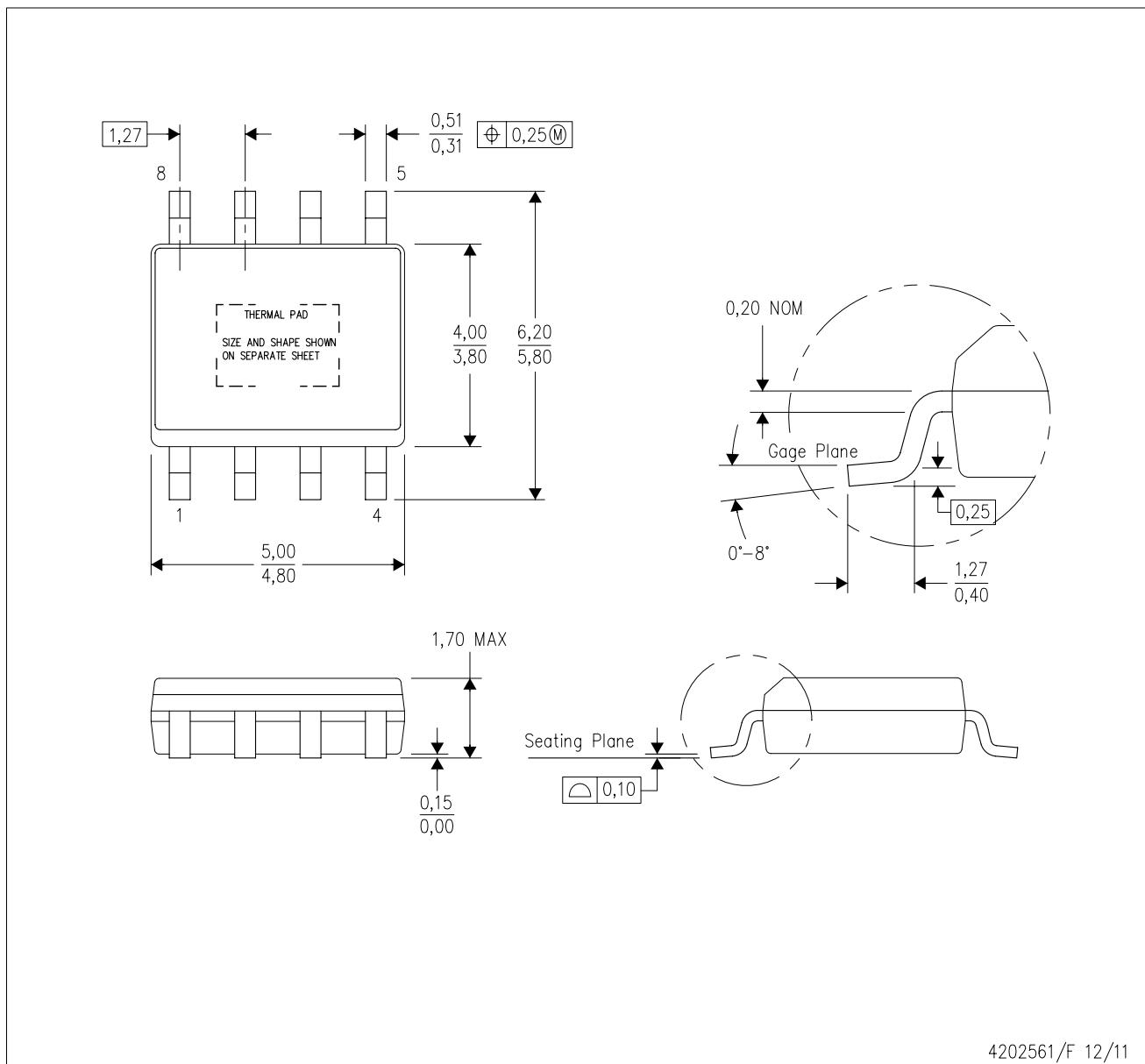
Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

4202561/G

MECHANICAL DATA

DDA (R-PDSO-G8)

PowerPAD™ PLASTIC SMALL-OUTLINE



4202561/F 12/11

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5-1994.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
 - D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at www.ti.com <<http://www.ti.com>>.
 - E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
 - F. This package complies to JEDEC MS-012 variation BA

PowerPAD is a trademark of Texas Instruments.

THERMAL PAD MECHANICAL DATA

DDA (R-PDSO-G8)

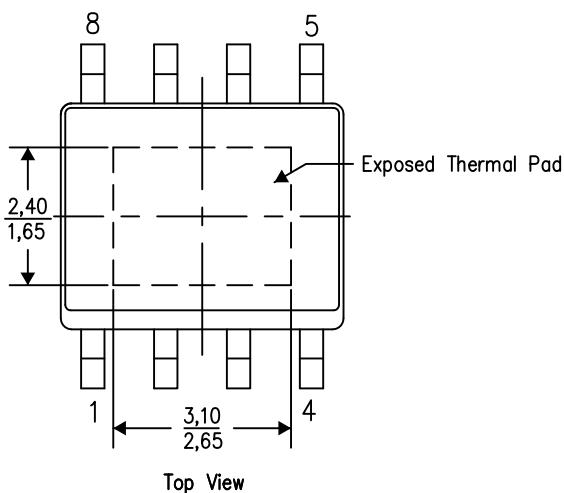
PowerPAD™ PLASTIC SMALL OUTLINE

THERMAL INFORMATION

This PowerPAD™ package incorporates an exposed thermal pad that is designed to be attached to a printed circuit board (PCB). The thermal pad must be soldered directly to the PCB. After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Exposed Thermal Pad Dimensions

4206322-6/L 05/12

NOTE: A. All linear dimensions are in millimeters

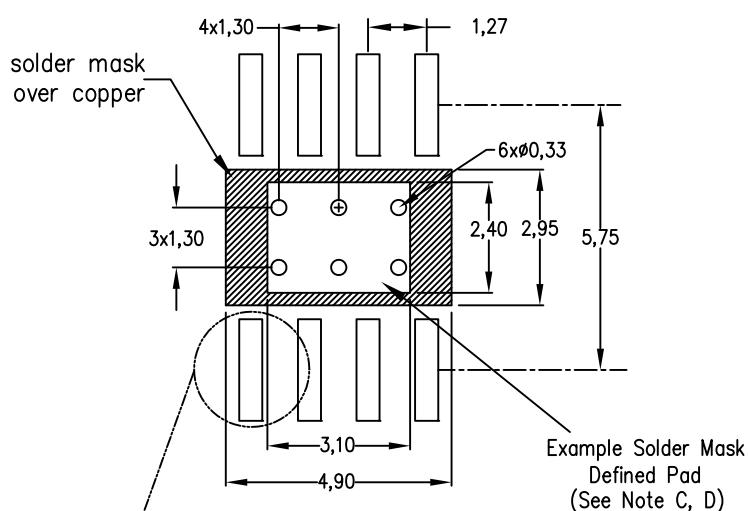
PowerPAD is a trademark of Texas Instruments

LAND PATTERN DATA

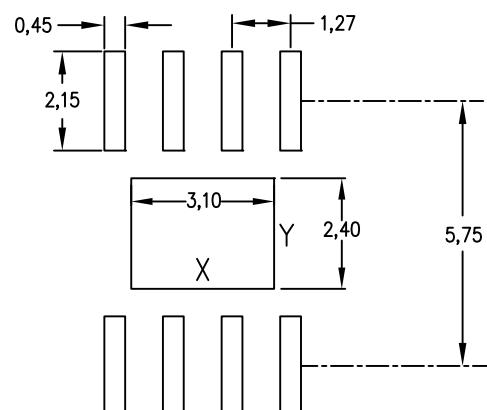
DDA (R-PDSO-G8)

PowerPAD™ PLASTIC SMALL OUTLINE

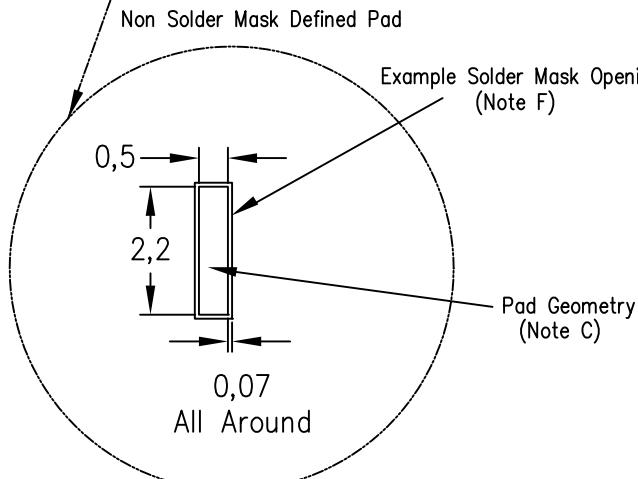
Example Board Layout
Via pattern and copper pad size
may vary depending on layout constraints



0,127mm Thick Stencil Design Example
Reference table below for other
solder stencil thicknesses
(Note E)



Example Solder Mask
Defined Pad
(See Note C, D)



Center Power Pad Solder Stencil Opening		
Stencil Thickness	X	Y
0.1mm	3.3	2.6
0.127mm	3.1	2.4
0.152mm	2.9	2.2
0.178mm	2.8	2.1

4208951-6/D 04/12

- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate designs.
 - D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <<http://www.ti.com>>. Publication IPC-7351 is recommended for alternate designs.
 - E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
 - F. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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